

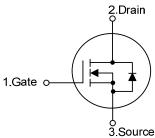
UNISONIC TECHNOLOGIES CO., LTD

6N70-CBQ **Preliminary Power MOSFET**

6A, 700V N-CHANNEL **POWER MOSFET**

have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

- * $R_{DS(ON)}$ < 2.8 Ω @ V_{GS} = 10V, I_{D} = 3.0A
- * Fast switching capability
- * Avalanche energy tested

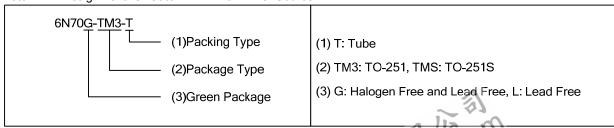


DESCRIPTION TO-251 The UTC 6N70-CBQ is a high voltage MOSFET designed to TO-251S **FEATURES** * Improved dv/dt capability, high ruggedness **SYMBOL**

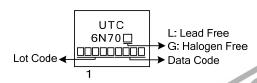
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N70L-TM3-T	6N70G-TM3-T	TO-251	G	D	S	Tube	
6N70L-TMS-T	6N70G-TMS-T	TO-251S	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	700	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I_{D}	6.0	Α
	Pulsed (Note 2)	I_{DM}	24	Α
Avalanche Current		I_{AR}	2.97	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	44	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	0.83	V/ns
Power Dissipation		P_{D}	55	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T_{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=10mH, I_{AS} =2.97A, V_{DD} =50V, R_{G} =25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 6.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ_{JC}	2.27	°C/W	

■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise specified)

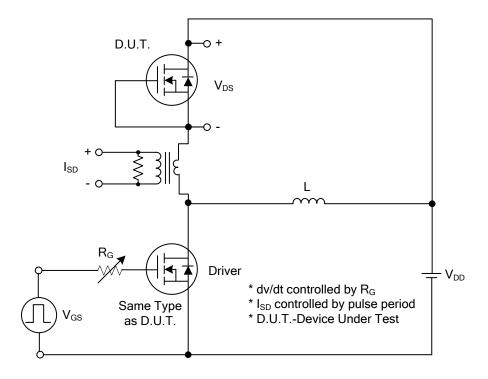
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0V, I_D =250 μ A	700			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =700V, V _{GS} =0V			1	μΑ
Gate- Source Leakage Current	Forward	lass	$V_{G=}30V$, $V_{DS}=0V$			100	nA
	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =3.0A			2.8	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	nput Capacitance				716		pF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0 MHz		61		pF
Reverse Transfer Capacitance		C_{RSS}]		11		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A		35.4		nC
Gate to Source Charge		Q_GS	$I_{G}=100\mu A$ (Note 1, 2)		3.2		nC
Gate to Drain Charge		Q_GD	IG-100μΑ (Note 1, 2)		4.2		nC
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$	V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A, R_{G} =25 Ω (Note 1, 2)		40		ns
Rise Time		t_R			12		ns
Turn-OFF Delay Time		$t_{D(OFF)}$			123		ns
Fall-Time		t_{F}			26		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Continuous Current		I _S	SE CO!	•		6.0	Α
Maximum Body-Diode Pulsed Current		I _{SM}	4 18 680.			24	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =6.0A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =6.0A, V _{GS} =0V		575		ns
Body Diode Reverse Recovery Charge		Q _{rr}	dl⊧/dt=200A/µs (Note 1)		1.98		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

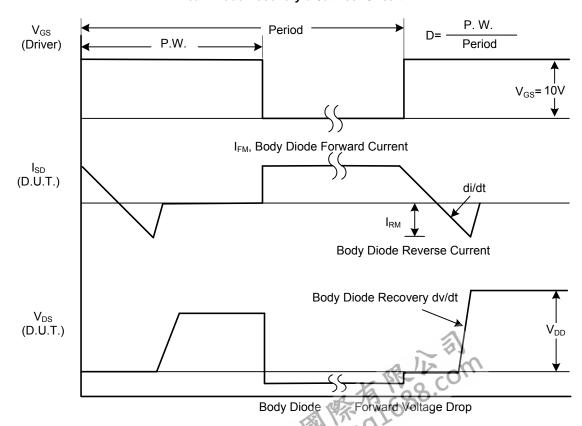
2. Essentially independent of operating temperature.



TEST CIRCUITS AND WAVEFORMS

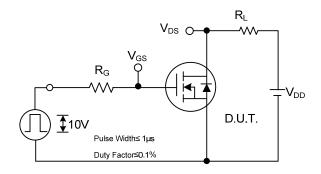


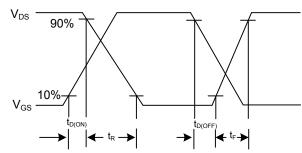
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

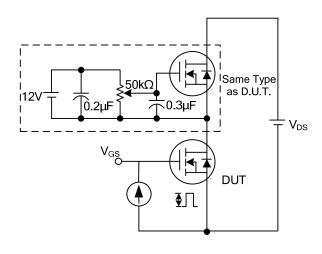
TEST CIRCUITS AND WAVEFORMS (Cont.)

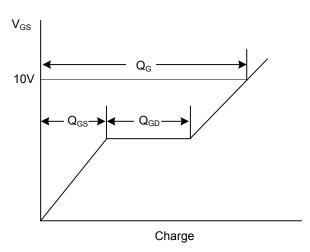




Switching Test Circuit

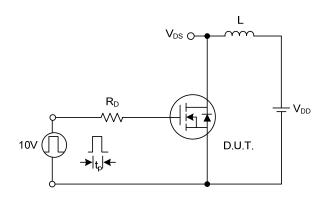
Switching Waveforms

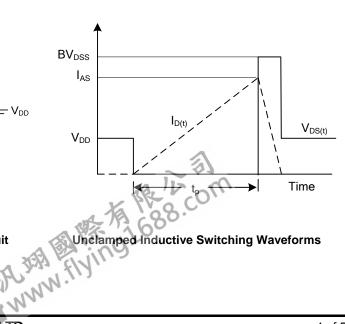




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

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